

MOS FIELD EFFECT TRANSISTOR $\mu PA621TT$

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA621TT is a switching device, which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 2.5 V drive available
- · Low on-state resistance

 $R_{DS(on)1} = 50 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, ID} = 2.5 \text{ A)}$

 $R_{DS(on)2} = 53 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.0 \text{ V, Ip} = 2.5 \text{ A)}$

RDS(on)3 = 79 m Ω MAX. (VGS = 2.5 V, ID = 2.5 A)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA621TT	6pinWSOF (1620)

Marking: WB

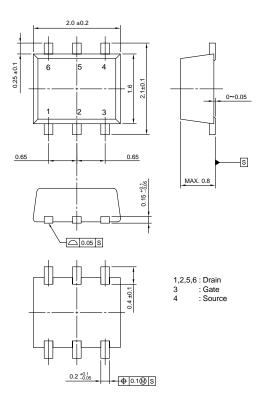
ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	20	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±12	V
Drain Current (DC) (T _A = 25°C)	ID(DC)	±5.0	Α
Drain Current (pulse) Note1	ID(pulse)	±20	Α
Total Power Dissipation	P _{T1}	0.2	W
Total Power Dissipation Note2	P _{T2}	1.4	W
Channel Temperature	Tch	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

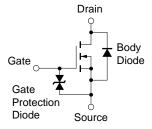
Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board, $t \le 5$ sec.

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT



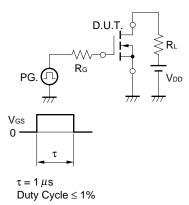
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

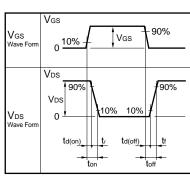
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ELECTRICAL CHARACTERISTICS (TA = 25°C)

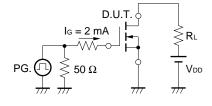
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V _{DS} = 20 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±12 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1.0 mA	0.5	1.0	1.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 2.5 A	1.0	4.8		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 4.5 V, ID = 2.5 A		40	50	mΩ
	RDS(on)2	V _G S = 4.0 V, I _D = 2.5 A		42	53	mΩ
	RDS(on)3	Vgs = 2.5 V, ID = 2.5 A		59	79	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		270		pF
Output Capacitance	Coss	Vgs = 0 V		80		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		60		pF
Turn-on Delay Time	td(on)	V _{DD} = 10 V, I _D = 2.5 A		30		ns
Rise Time	tr	Vgs = 4.0 V		200		ns
Turn-off Delay Time	t _{d(off)}	$R_G = 10 \Omega$		120		ns
Fall Time	t f			160		ns
Total Gate Charge	Q _G	V _{DD} = 16 V		3.3		nC
Gate to Source Charge	Qgs	Vgs = 4.0 V		0.7		nC
Gate to Drain Charge	Q _{GD}	ID = 5.0 A		1.8		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 5.0 A, VGS = 0 V		0.90		V

TEST CIRCUIT 1 SWITCHING TIME

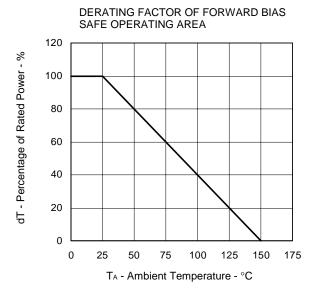


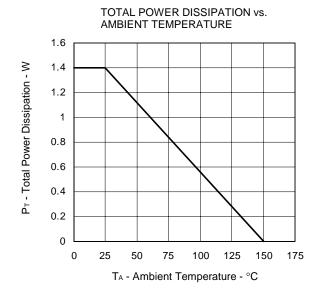


TEST CIRCUIT 2 GATE CHARGE

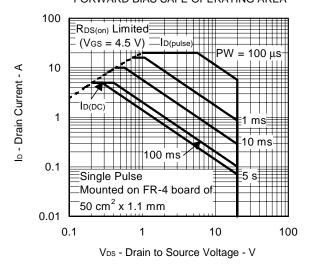


TYPICAL CHARACTERISTICS (TA = 25°C)

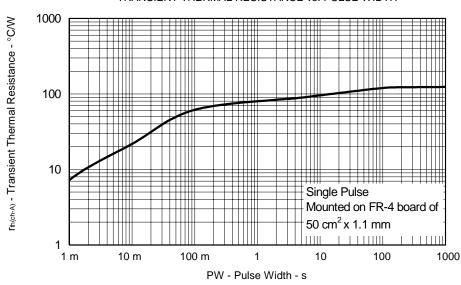




FORWARD BIAS SAFE OPERATING AREA



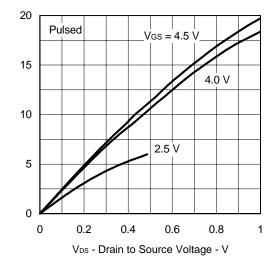
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



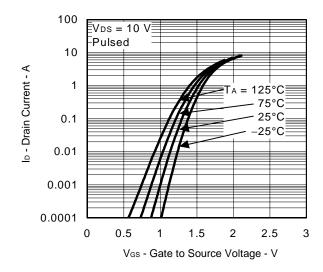
3

lo - Drain Current - A

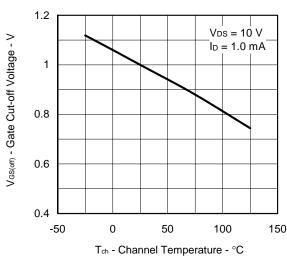
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



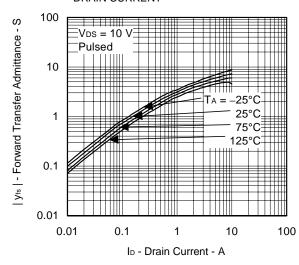
FORWARD TRANSFER CHARACTERISTICS



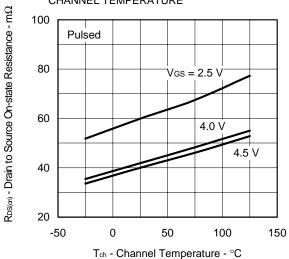
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



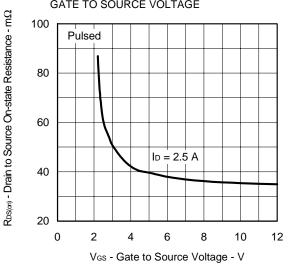
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

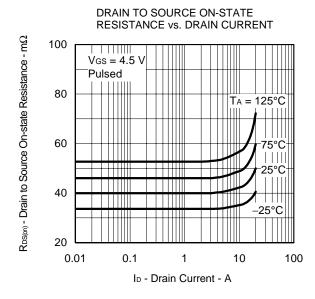


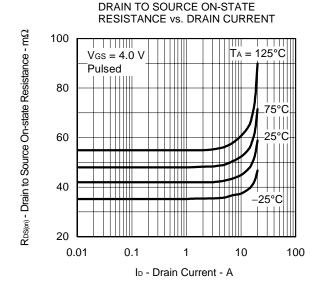
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

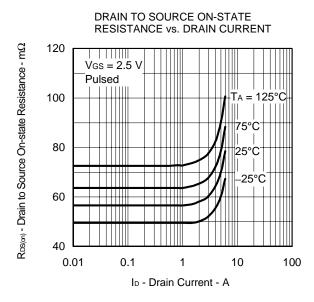


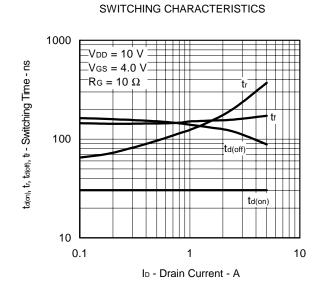
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

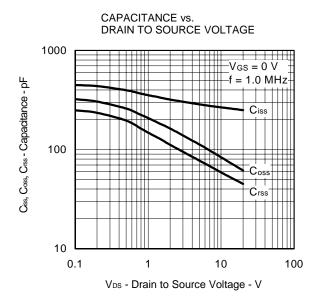


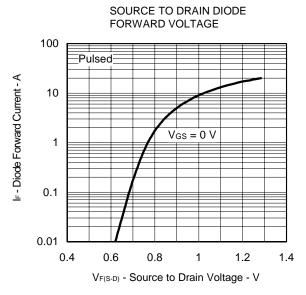




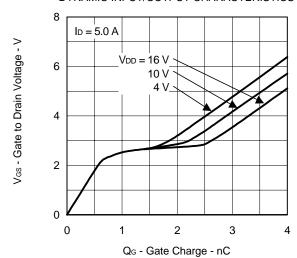








DYNAMIC INPUT/OUTPUT CHARACTERISTICS



NEC μ PA621TT

[MEMO]

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